Ewald summation for ion-dipole mixture under
dielectric confinement

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Abstract

A modified 3D-Ewald summation is presented for accurately simulating the ion-
dipole mixture under dielectric confinement. The method is based on the combination
of image charges and image dipoles with the conventional Ewald summation and has a
scaling $O(N^{3/2})$. The accuracy and efficiency of our algorithm are examined through
numerical examples.

1 Introduction

The structure of electrolytes near interfaces is fundamentally important in a variety of scientific
and industrial applications such as controlling the colloidal stability,\cite{1,2} self-assembled structure
of nanoparticles,\cite{3,4} and in growing photonic crystals for manipulating light.\cite{5} The primitive
model of electrolytes where ions are described as charged hard spheres and solvent is modeled
as a dielectric continuum has been studied extensively for producing the ion distribution
and deciphering the critical behavior.\cite{6,7} However, one main issue of the primitive model is
that it lacks a description of the molecular nature of the solvent, and thus can not capture
effects such as the emergence of an oriented hydration layer at the solid–fluid interface.\cite{10}
To take into account the effect of the explicit solvent, various nonprimitive models were developed where both ions and solvent are modeled at the molecular level. One of the simplest nonprimitive models is the ion-dipole mixture where the solvent molecules are represented as hard spheres with dipole moments. Such a nonprimitive model of ion-dipole mixture captures basic features of the system: the short-ranged repulsions, the long-ranged ion-ion, and ion-dipole electrostatics, and orientation-dependent dipole-dipole electrostatics.

Accordingly, the model of ion-dipole mixture near interfaces has received considerable attention in theoretical and computational studies. Prior simulations have deciphered the impact of surface charges, magnitudes of dipole moment, and ionic strength on the interfacial dipole and ionic structure. However, a parameter that has been frequently ignored is the dielectric mismatch between the ion-dipole containing region and the substrate. Nevertheless, the presence of surface polarization can be crucial in regulating the dynamics and structures of the system. Simulations have suggested that the dielectric many-body effect suppresses ion mobility near insulating interfaces and enhances it near conducting interfaces. Surface polarization has also been shown to significantly affect polyelectrolyte adsorption, structure of electrolyte, and differential capacitance in a polyelectrolyte-based super-capacitor, to name a few.

Developing numerical methods for modeling spatially varying permittivity is a research topic of significant interest. Here we focus on the slab geometry consisting of two planar dielectric interfaces. While image charges can be easily constructed to determine the electrostatic potential of a point charge near a single planar interface, in the presence of a second interface an infinite number of image charges emerge by consecutive reflections. Image charges have been incorporated into numerous fast electrostatic solvers, including ICM-MMM2D [scaling $O(N^3)$, $N$ is the particle number], electrostatic layer correction method [ICM-ELC, scaling $O(N \log N)$], and ICM-Ewald with slab correction [scaling $O(N^{3/2})$]. However, all the existing algorithms developed above are only available for the system where there are only point charges, and numerical methods for modeling ion-dipole mixture between
dielectric interfaces are still lacking. This motivates our present work—we generalize a previously formulated ICM-Ewald\textsuperscript{23} that makes it possible to simulate ion-dipole mixture between dielectric interfaces with asymmetric dielectric contrasts.

The paper is organized as follows. In Section 2 we present a description of the model system (Section 2.1) and present the definition of electrostatic energy (Section 2.2). We then demonstrate how image charges and image dipoles can be incorporated into conventional Ewald summation (Section 2.3). In Section 3 we examine the accuracy and efficiency of our method. Finally, our conclusion and future directions are summarized in Section 4.

2 Model and algorithm

2.1 Sandwiched dielectric confinement

We consider the system which is 2D-periodic in $x-y$ plane with the dimension $[0, L_x] \times [0, L_y] \times [-l_z/2, l_z/2]$, as depicted in Figure 1. Two dielectric interfaces are located at $z = L/2$ and $z = -L/2$ ($L < l_z$), separating the whole region into three layers. From the top to the bottom, they are labelled as A, B, and C with dielectric permittivity $\kappa_a$, $\kappa_b$, and $\kappa_c$. A collection of $N$ mobile particles, characterized by $\{q_i, p_i, r_i\}$ ($i \in Z[1, N], Z$ is the integer set) is confined in the middle layer, where $q_i, p_i, \text{and } r_i$ represent the charge, dipole, and position of particle $i$, respectively. The dielectric discontinuity of each interface is given by $\gamma_{ba} = (\kappa_b - \kappa_a)/(\kappa_b + \kappa_a)$ and $\gamma_{bc} = (\kappa_b - \kappa_c)/(\kappa_b + \kappa_c)$. In the presence of dielectric interfaces, ions and dipoles induce surface polarization charge which is conveniently represented by image charges and image dipoles.\textsuperscript{25} These images get reflected between the two interfaces with their magnitude weakened by powers of $\gamma_{ba}$ and $\gamma_{bc}$. We use the notation $\gamma^+_m$ and $\gamma^-_m$ to represent these factors for the $m^{th}$ order image charge and image dipole in the layer A and C (the sign + and − correspond to the layer A and C). Specifically, the magnitude of the $m^{th}$
order image charge $q_{jm}^\pm$ and image dipole $p_{jm}^\pm$ are given by,

$$
q_{jm}^\pm = \gamma_m^\pm q_j, \quad p_{jm}^\pm = \gamma_m^\pm p_j \quad p_{jmy}^\pm = \gamma_m^\pm p_j y, \quad p_{jmx}^\pm = (-1)^m \gamma_m^\pm p_j x, \quad (1)
$$

where $\gamma_m^+ = \gamma_{ba}^{[\frac{m}{2}]} \gamma_{bc}^{[\frac{m}{2}]}$ and $\gamma_m^- = \gamma_{ba}^{[\frac{m}{2}]} \gamma_{bc}^{[\frac{m}{2}]}$, $\lfloor x \rfloor \ (\lceil x \rceil)$ represents the smallest (largest) integer larger (smaller) than or equal to $x$, and $m \in \mathbb{Z}[1, \infty]$. A position pattern also exists for these image charges and image dipoles—the coordinate $r_{jm}^\pm$ of the $m^{th}$ order image is

$$
x_{jm}^\pm = x_j, \quad y_{jm}^\pm = y_j, \quad z_{jm}^\pm = (-1)^m z_j \pm mL. \quad (2)
$$

![Figure 1: Schematic of an ion-dipole mixture between two dielectric interfaces separated by a distance $L$. From top to bottom, the dielectric permittivities of the three layers A, B, and C are $\kappa_a$, $\kappa_b$, and $\kappa_c$, respectively. The sphere in the middle layer denotes a mobile particle with charge $q$ and dipole $p$ and dashed circles in the layers A and C represent its first-order image charges and image dipoles.](image)

### 2.2 Electrostatic energy

For two charge-dipoles $(q_i, p_i, r_i)$ and $(q_j, p_j, r_j)$, the pairwise electrostatic energy is given by

$$
\kappa_b U(q_i, p_i, r_i; q_j, p_j, r_j; n) = (q_i + p_i \cdot \nabla_i)(q_j + p_j \cdot \nabla_j) \frac{1}{|r_i - r_j - n|}, \quad (3)
$$
where \( n = (n_x, n_y, 0) \) represents the infinite replicas of the center cell and \( n_x \) and \( n_y \) are positive and negative integers. The total electrostatic energy between mobile ions, dipoles and all the images reads

\[
\kappa_b E_{\text{tot}} = \frac{1}{2} \sum_{n} \sum_{i=1}^{\infty} \sum_{j=1}^{N} U(q_i, p_i, r_i; q_j, p_j, r_j; n)
+ \frac{1}{2} \sum_{n} \sum_{i=1}^{\infty} \sum_{m=1}^{\infty} \sum_{j=1}^{N} U(q_i, p_i, r_i; q_{jm}, p_{jm}, r_{jm}; n)
+ \frac{1}{2} \sum_{n} \sum_{i=1}^{\infty} \sum_{m=1}^{\infty} \sum_{j=1}^{N} U(q_i, p_i, r_i; q_{jm}, p_{jm}, r_{jm}; n),
\]

where the prime indicates that the term \( i = j \) should be omitted when \( n = (0, 0, 0) \). Our goal is thus to calculate the \( E_{\text{tot}} \) for a given ion and dipole configuration. However, the direct evaluation of energy \( E_{\text{tot}} \) by Equation 4 is very expensive because of the slow conditional convergence and the scaling \( O(N^2) \) where \( N \) is the particle number. To overcome this issue, we adopt the 3D-Ewald summation with slab correction term (EW3DC)\(^{28}\) which is accurate and efficient for the parallel plate geometry with 2D-periodicity, and incorporate image charges (IC) and image dipoles (ID) into the EW3DC. The method we developed, termed as ICID-Ewald, is a generalization of the ICM-Ewald\(^{23}\) which is only available for ions.

### 2.3 Ewald summation

The essential idea of Ewald summation\(^{29}\) is that for the long-range interaction \( 1/r \), we can divide that into the short-ranged part \( \text{erfc}(\alpha r)/r \) and the long-ranged part \( \text{erf}(\alpha r)/r \) (\( \alpha \) is a damping factor) and then evaluate the long-range part in reciprocal space. Following this,
The short-ranged contribution $E_{\text{short}}$ in $E_{\text{tot}}$ is given by

$$
\kappa_b E_{\text{short}} = \frac{1}{2} \sum_{n}^{\infty} \sum_{i=1}^{N} \sum_{j=1}^{N} (q_i + p_i \cdot \nabla_i)(q_j + p_j \cdot \nabla_j) \frac{\text{erfc}(\alpha |\mathbf{r}_i - \mathbf{r}_j - \mathbf{n}|)}{|\mathbf{r}_i - \mathbf{r}_j - \mathbf{n}|}
$$

$$
+ \frac{1}{2} \sum_{n}^{\infty} \sum_{i=1}^{N} \sum_{m=1}^{N} \sum_{j=1}^{N} (q_i + p_i \cdot \nabla_i)(q_{jm}^+ + p_{jm}^+ \cdot \nabla_{jm}^+) \frac{\text{erfc}(\alpha |\mathbf{r}_i - \mathbf{r}_{jm}^+ - \mathbf{n}|)}{|\mathbf{r}_i - \mathbf{r}_{jm}^+ - \mathbf{n}|}
$$

$$
+ \frac{1}{2} \sum_{n}^{\infty} \sum_{i=1}^{N} \sum_{m=1}^{N} \sum_{j=1}^{N} (q_i + p_i \cdot \nabla_i)(q_{jm}^- + p_{jm}^- \cdot \nabla_{jm}^-) \frac{\text{erfc}(\alpha |\mathbf{r}_i - \mathbf{r}_{jm}^- - \mathbf{n}|)}{|\mathbf{r}_i - \mathbf{r}_{jm}^- - \mathbf{n}|}
$$

$$
= \frac{1}{2} \sum_{n}^{\infty} \sum_{i=1}^{N} \sum_{j=1}^{N} (q_i + p_i \cdot \nabla_i)(q_j + p_j \cdot \nabla_j) \frac{\text{erfc}(\alpha |\mathbf{r}_i - \mathbf{r}_j - \mathbf{n}|)}{|\mathbf{r}_i - \mathbf{r}_j - \mathbf{n}|}
$$

$$
+ \frac{1}{2} \sum_{n}^{\infty} \sum_{i=1}^{N} \sum_{m=1}^{N} \sum_{j=1}^{N} \gamma_m^+(q_i + p_i \cdot \nabla_i)(q_j + p_j \cdot \nabla_j) \frac{\text{erfc}(\alpha |\mathbf{r}_i - \mathbf{r}_{jm}^+ - \mathbf{n}|)}{|\mathbf{r}_i - \mathbf{r}_{jm}^+ - \mathbf{n}|}
$$

$$
+ \frac{1}{2} \sum_{n}^{\infty} \sum_{i=1}^{N} \sum_{m=1}^{N} \sum_{j=1}^{N} \gamma_m^-(q_i + p_i \cdot \nabla_i)(q_j + p_j \cdot \nabla_j) \frac{\text{erfc}(\alpha |\mathbf{r}_i - \mathbf{r}_{jm}^- - \mathbf{n}|)}{|\mathbf{r}_i - \mathbf{r}_{jm}^- - \mathbf{n}|}.
$$

Equation (5)

To remove the prime over the summation in the long-ranged part so that we can conveniently apply Fourier transformation later, we need to subtract the following self-energy which reads

$$
\kappa_b E_{\text{self}} = \frac{1}{2} \sum_{i=1}^{N} (q_i + p_i \cdot \nabla_i)^2 \lim_{\mathbf{r}_i \to 0} \frac{\text{erfc}(\alpha |\mathbf{r}_i|)}{|\mathbf{r}_i|}.
$$

Equation (6)

Based on the Taylor series expansion $\text{erf}(x) \approx (2/\sqrt{\pi})(x - x^3/3) + O(x^5)$, Equation (6) is reduced to

$$
\kappa_b E_{\text{self}} = \frac{\alpha}{\sqrt{\pi}} \left( \sum_{i=1}^{N} q_i^2 + \sum_{i=1}^{N} \frac{2\alpha^2}{3} |p_i|^2 \right).
$$

Equation (7)
The long-ranged contribution $E_{\text{long}}$ in real-space is

$$
\kappa_b E_{\text{long}} = \frac{1}{2} \sum_{n}^{\infty} \sum_{i=1}^{N} \sum_{j=1}^{N} (q_i + p_i \cdot \nabla_i)(q_j + p_j \cdot \nabla_j) \frac{\text{erf}(\alpha |r_i - r_j - n|)}{|r_i - r_j - n|}
$$

$$
+ \frac{1}{2} \sum_{n}^{\infty} \sum_{i=1}^{N} \sum_{m=1}^{\infty} \sum_{j=1}^{N} \gamma_m^+(q_i + p_i \cdot \nabla_i)(q_j + p_j \cdot \nabla_j) \frac{\text{erf}(\alpha |r_i - r_{jm}^+ - n|)}{|r_i - r_{jm}^+ - n|}
$$

$$
+ \frac{1}{2} \sum_{n}^{\infty} \sum_{i=1}^{N} \sum_{m=1}^{\infty} \sum_{j=1}^{N} \gamma_m^-(q_i + p_i \cdot \nabla_i)(q_j + p_j \cdot \nabla_j) \frac{\text{erf}(\alpha |r_i - r_{jm}^- - n|)}{|r_i - r_{jm}^- - n|}.
$$

(8)

Using the inverse Fourier transform, $E_{\text{long}}$ can be rewritten in the reciprocal space as,

$$
\kappa_b E_{\text{long}} = \frac{1}{2} \sum_{k \neq 0}^{\infty} \frac{4\pi}{|k|^2} \exp\left(-\frac{|k|^2}{4\alpha^2}\right) \left[ \sum_{i=1}^{N} (q_i + p_i \cdot \nabla_i) \exp(ik \cdot r_i) \right]
$$

$$
\times \sum_{j=1}^{N} (q_j + p_j \cdot \nabla_j) \left[ \exp(-ik \cdot r_j) + \sum_{m=1}^{\infty} (\gamma_m^+ \exp(-ik \cdot r_{jm}^+) + \gamma_m^- \exp(-ik \cdot r_{jm}^-)) \right],
$$

(9)

where $k = (2\pi n_x/L_x, 2\pi n_y/L_y, 2\pi n_z/L_z)$ and $(n_x, n_y, n_z) \in \mathbb{Z}^3$. We further simplify Equation
\[
\kappa_b E_{kang} = \frac{1}{2} \sum_{k \neq 0}^{\infty} \frac{4\pi}{V|k|^2} \exp\left(-\frac{|k|^2}{4\alpha^2}\right) \left[ \sum_{i=1}^{N} (q_i + p_i \cdot \nabla_i) \exp(i k \cdot r_i) \right] \\
\times \left\{ \sum_{j=1}^{N} (q_j + p_j \cdot \nabla_j) \exp(-ik_x x_j - ik_y y_j) \right. \\
\times \left[ 1 + B_{rl}(k) - iB_{im}(k) \right] \exp(-i k_z z_j) + \left[ A_{rl}(k) - iA_{im}(k) \right] \exp(+i k_z z_j) \right\}, \quad (10)
\]

where

\[ A_{rl}(k) = \text{Re} \left[ \sum_{m=1, \text{odd}}^{\infty} (\gamma_m^+ \exp(i k_z m L) + \gamma_m^- \exp(-i k_z m L)) \right], \quad (11) \]

\[ A_{im}(k) = \text{Im} \left[ \sum_{m=1, \text{odd}}^{\infty} (\gamma_m^+ \exp(i k_z m L) + \gamma_m^- \exp(-i k_z m L)) \right], \quad (12) \]

\[ B_{rl}(k) = \text{Re} \left[ \sum_{m=1, \text{even}}^{\infty} (\gamma_m^+ \exp(i k_z m L) + \gamma_m^- \exp(-i k_z m L)) \right], \quad (13) \]

\[ B_{im}(k) = \text{Im} \left[ \sum_{m=1, \text{even}}^{\infty} (\gamma_m^+ \exp(i k_z m L) + \gamma_m^- \exp(-i k_z m L)) \right], \quad (14) \]

and \( \tilde{k} = (k_x, k_y, -k_z) \). By symmetry relation \( B_{im}(k) = -B_{im}(-k) \), Equation 10 can be
further reduced to be

\[
\kappa_b E_{\text{long}} = \frac{1}{2} \sum_{k \neq 0}^{\infty} \frac{4\pi}{|k|^2} \exp\left(-\frac{|k|^2}{4\alpha^2}\right) \left[ \sum_{i=1}^{N} (q_i + i\mathbf{p}_i \cdot \mathbf{k}) \exp(i\mathbf{k} \cdot \mathbf{r}_i) \right] \\
\times \left\{ \sum_{j=1}^{N} (q_j - i\mathbf{p}_j \cdot \mathbf{k}) \exp(-ik_x x_j - ik_y y_j) \left[ 1 + B_{\text{nl}}(\mathbf{k}) \right] \exp(-ik_z z_j) \right. \\
+ \left. \sum_{j=1}^{N} (q_j - i\mathbf{p}_j \cdot \tilde{\mathbf{k}}) \exp(-ik_x x_j - ik_y y_j) \left[ A_{\text{rl}}(\mathbf{k}) - iA_{\text{im}}(\mathbf{k}) \right] \exp(+ik_z z_j) \right\} .
\]

(15)

Note that Equation 15 has an obvious benefit: charges and dipoles can be assigned onto grids so that fast Fourier transformation (FFT) can be employed for faster speed—the main idea of particle-mesh Ewald\textsuperscript{30}

For the parallel plate geometry with 2D-periodicity, it has been found that 3D Ewald summation with slab correction\textsuperscript{28} can give the accurate results as in the 2D-Ewald summation,\textsuperscript{31,32} and most importantly, reduces the scaling from \(O(N^{5/3})\) to \(O(N^{3/2})\). Following Yeh and Berkowitz\textsuperscript{28} we derive the slab correction term that takes the image charges and image dipoles into account, which is given by

\[
\kappa_b E_{\text{slab}} = -\frac{\pi}{V} \sum_{i=1}^{N} (q_i + \mathbf{p}_i \cdot \nabla_i) \left[ \sum_{j=1}^{N} (q_j + \mathbf{p}_j \cdot \nabla_j) (z_i - z_j)^2 + \right.
\]

\[
\sum_{m=1}^{\infty} \sum_{j=1}^{N} \left[ \gamma^+_{\text{m}}(q_j + \mathbf{p}_j \cdot \nabla_j)(z_i - z_{jm}^+)^2 + \gamma^-_{\text{m}}(q_j + \mathbf{p}_j \cdot \nabla_j)(z_i - z_{jm}^-)^2 \right] \right] .
\]

(16)

Substituting the \(z_{jm}^\pm\) into Eq. 16, taking into account the neutrality condition \((\sum_{i=1}^{N} q_i) = 0\), and calculating the derivatives explicitly lead to

\[
\kappa_b E_{\text{slab}} = \frac{2\pi}{V} \left( \sum_{i=1}^{N} q_i z_i + \sum_{i=1}^{N} \mathbf{p}_{iz} \right)^2 \left[ 1 + \sum_{m=1}^{\infty} (-1)^m (\gamma^+_m + \gamma^-_m) \right] .
\]

(17)

The total electrostatic energy is then calculated as

\[
E_{\text{tot}} = E_{\text{short}} + E_{\text{long}} + E_{\text{slab}} - E_{\text{self}} .
\]

(18)
In practice, the infinite summation over the index \( m \) needs to be truncated at a finite \( M \). The necessary \( M \) for the short-range part \( E_{\text{short}} \), which we denote as \( M_s \), simply requires
\[ M_s = \lceil r_{\text{cut}} / L \rceil, \]
where \( r_{\text{cut}} \) is the real-space cutoff radius. The necessary \( M \) for the long-range part \( E_{\text{long}} \), which we denote as \( M_l \), depends on the magnitude of dielectric contrasts, system size, ion valency, etc., and should be tested on a system basis.

3 Numerical results

3.1 Accuracy benchmark

We study a system containing 10 divalent cations (\( q = +2e \)), 20 monovalent anions (\( q = -e \)), and 30 dipolar particles with \( |p| = e\sigma \). These mobile particles are modeled as hard-spheres (diameter \( \sigma \)) that interact via shifted-truncated Lennard-Jones (LJ) potential with energy scale \( \varepsilon_{\text{LJ}} = k_B T \), where \( k_B \) is the Boltzmann constant and \( T \) is the temperature. The dimensions of the simulated system are \( l_z = 15\sigma \) and \( L_x = L_y = 15\sigma \), and the particles are confined in the middle region of the simulation box by purely repulsive LJ walls (\( \varepsilon_{\text{wall}} = \varepsilon_{\text{LJ}}; \sigma_{\text{wall}} = 0.5\sigma \)) at \( z = -2.5\sigma \) and \( z = 2.5\sigma \). The Bjerrum length of the system is \( l_B = e^2 / (4\pi\varepsilon_{\text{sol}} k_B T) = \sigma \). We utilize the ICID-Ewald developed in this work to calculate the electrostatic energies (\( E_{\text{img}} \)) over \( N_{\text{conf}} = 500 \) randomly generated configurations at varying dielectric contrasts. The Ewald calculation is performed by setting the cutoff \( r_{\text{cut}} = 7.5\sigma \), and we use \( M_s = 1 \) as real-space truncation reflections and \( M_l = 5 \) as reciprocal-space reflections. The slab factor \( n_{\text{slab}} \) is chosen as \( n_{\text{slab}} = 5 \). To validate the accuracy of our method, we compare our results to the energy \( E_{\text{direct}} \) obtained from the direct summation with sufficiently large \( n \) (Equation 4) and plot the relative deviation \( |E_{\text{img}} - E_{\text{direct}}| / |E_{\text{direct}}| \) as a function of configuration ID number (0–500) in Figure 2. We observe that for most of the configurations, the relative deviation of the individual configuration is smaller than \( 10^{-6} \) which is sufficient for practical simulations.
Figure 2: Relative deviation $|E_{\text{img}} - E_{\text{direct}}|/|E_{\text{direct}}|$ (see text for definition) for 500 configurations of 60 particles randomly distributed in a box of dimension $l_z = 15\sigma$ and $L_x = L_y = 15\sigma$ at different dielectric mismatches $\gamma_{ba}$ and $\gamma_{bc}$. Dots denote the errors of the individual configurations.

### 3.2 CPU time

For testing the CPU performance, we study the same system as described in Sec. 3.1 and vary the particle number $N$. We use an equal number of ions and dipoles. For the ICID-Ewald we again utilize $M_s = 1$ and $M_l = 5$ for the number of real and reciprocal reflections, respectively.
To obtain the CPU time as a function of particle number, we scale the number of ions from $N = 36$ to $N = 3996$. For each $N$ studied, we perform a set of test simulations at varying $r_{\text{cut}}/\sigma \in \mathbb{Z}[2, 10]$ to obtain the optimal choice that produces the lowest CPU time. Using this optimal cutoff, we then calculate electrostatic energies of 500 independent configurations for statistics. As expected, we observed the $O(N^{3/2})$ scaling for ICID-Ewald in Figure 3. Also, we find the incorporation of image charges and image dipoles and the extra space to accommodate images make the ICID-Ewald consume more CPU time compared to the standard Ewald summation. However, for $N \geq 2000$ the ICID-Ewald merely results in an approximately 25% increase in the CPU time.

![Figure 3: Comparison of the CPU consumed per step as a function of the particle number $N$ for the ICID-Ewald and standard Ewald. The linear fitting (black straight line) of CPU time of ICID-Ewald confirms the expected $O(N^{3/2})$ scaling.](image)

4 Conclusion

In conclusion, we have presented an extension to the previous ICM-Ewald that makes it available for simulating ion-dipole mixture between dielectric interfaces at a computational cost of $O(N^{3/2})$. This efficient and accurate method is based on the combination of image charges and image dipoles with conventional Ewald summation and can be easily implemented to standard simulation packages. The efficient implementation of our method for Monte Carlo simulations and the systematic investigation of ion-dipole mixture near dielectric interfaces
are our ongoing projects.

References


